Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/611,923	YONENO ET AL.
Examiner	Art Unit

Prabodh M. Dharia

2629

SEARCHED					
Class	Subclass	Date	Examiner		
345	156-159 864,784, 173-179 169	7/23/2006	PD		
379	93.37				
345	184				
235	462.45				
382	115				
709	229				
455	556				
715	864				
		-			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
East Text Search (US-PGPUB; USPAT;EPO;JPO;DERWENT;IBM_T DB)	7/23/2006	PD
Assisted by Vijay Shankar		
Henry Tran		
Xiao M Wu		
Amare Mengistu		
Kent Chang		